

# **BIPN60015C**

### Intelligent Power Module

### **General Description**

BIPN60015C is an advanced intelligent power module that BYD has newly developed and designed to provide very compact and high performance as ac motor drivers mainly targeting low-power inverter-driven applications like air conditioner and washing machine. It combines optimized circuit protection and drive matched to low-loss IGBT. System reliability is further enhanced by the integrated under-voltage lock-out and Over-current protection. The high speed built-in HVIC provides optocoupler less single-supply IGBT gate driving capability that further reduce the over all size of the inverter system design. Each phase current of inverter can be monitored separately due to the divided negative dc terminals.

### **Applications**

- Three-phase inverter drive for small power ac motor control
- Home appliances applications like air conditioner and washing machine

# Package BIP27-4426 Features

- Very low thermal resistance due to using DBC
- 600V-15A 3-phase IGBT inverter bridge including control ICs for gate driving and protection
- Divided negative dc-link terminals for inverter current sensing applications
- Single-grounded power supply due to built-in HVIC and bootstrap diode
- Isolation rating of 2500Vrms/min



### **Typical Application Circuit**

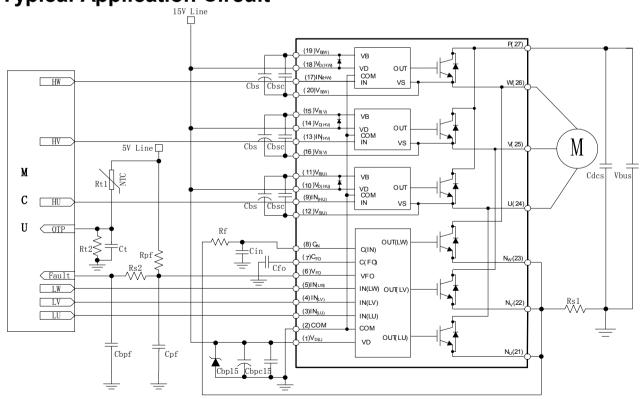


Fig 1. Typical Application Circuit

### **Pin Configuration**

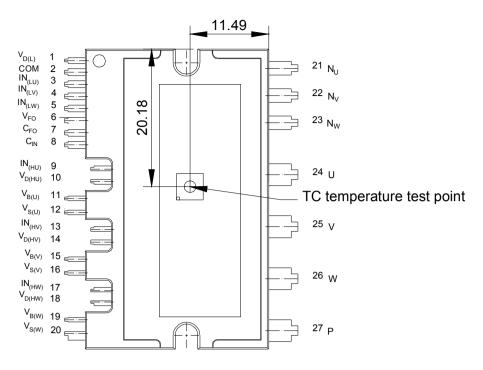


Fig 2. Pin Configuration(Top View)

# **Pin Descriptions**

Pin	Name	Descriptions
1	$V_{D(L)}$	Low-side common bias voltage for IC and IGBTs driving
2	COM	Common supply ground
3	IN <sub>(LU)</sub>	Signal input for low-side U phase
4	IN <sub>(LV)</sub>	Signal input for low-side V phase
5	IN <sub>(LW)</sub>	Signal input for low-side W phase
6	$V_{FO}$	Fault output
7	$C_{FO}$	Capacitor for fault output duration time selection
8	C <sub>IN</sub>	Capacitor (low-pass Filter) for over-current detection input
9	IN <sub>(HU</sub>	Signal input for high-side U phase
10	$V_{D(HU)}$	High-side bias voltage for U phase IC
11	$V_{B(U)}$	High-side bias voltage for U phase IGBT driving
12	$V_{S(U)}$	High-side bias voltage ground for U phase IGBT driving
13	IN <sub>(HV)</sub>	Signal input for high-side V phase
14	$V_{D(HV)}$	High-side bias voltage for V phase IC
15	$V_{B(V)}$	High-side bias voltage for V phase IGBT driving
16	$V_{S(V)}$	High-side bias voltage ground for V phase IGBT driving
17	IN <sub>(HW)</sub>	Signal input for high-side W phase
18	$V_{D(HW)}$	High-side bias voltage for w phase IC
19	$V_{B(W)}$	High-side bias voltage for w Phase IGBT driving
20	V <sub>S(W)</sub>	High-side bias voltage ground for W phase IGBT driving
21	Nυ	Negative dc-link input for U phase
22	N <sub>V</sub>	Negative dc–link input for V phase
23	N <sub>W</sub>	Negative dc–link input for W phase
24	U	Output for U phase

25	V	Output for V phase
26	W	Output for W phase
27	Р	Positive dc-link input

# **Absolute Maximum Ratings** (T<sub>J</sub> = 25°C, unless otherwise noted)

### **Inverter Part**

Symbol	Parameter	Conditions	Ratings	Units
$V_{PN}$	Supply voltage	Applied between P-N $_{\rm U}$ , N $_{\rm V}$ , N $_{\rm W}$	450	V
V <sub>PN</sub> (surge)	Supply voltage (surge)	Applied between P-N $_{\rm U}$ , N $_{\rm V}$ , N $_{\rm W}$	500	V
V <sub>CES</sub>	Collector-emitter voltage	V <sub>GE</sub> =0V,I <sub>CES</sub> =100uA,T <sub>J</sub> =25°C	600	V
±l <sub>C</sub>	Each IGBT collector current	T <sub>C</sub> = 25°C	15	Α
±l <sub>CP</sub>	Each IGBT collector current (peak)	T <sub>C</sub> = 25°C , less than 1ms	30	Α
Pc	Collector dissipation	T <sub>C</sub> = 25°C, per 1 chip	50	W
TJ	Junction temperature	(Note 1)	-20~+125	°C

**Note 1 :** The maximum junction temperature rating of the power chips integrated within the IPM is  $150^{\circ}$ C (@  $T_{c} \le 100^{\circ}$ C). However, to ensure safe operation of the IPM, the average junction temperature should be limited to  $T_{J}$  (ave)  $\le 125^{\circ}$ C (@  $T_{c} \le 100^{\circ}$ C).

### **Control Part**

Symbol	Parameter	Conditions	Ratings	Units
V <sub>D</sub>	Control supply voltage	Applied between $V_{D(HU)}$ , $V_{D(HV)}$ , $V_{D(HW)}$ , $V_{D(L)}$ -COM	20	V
V <sub>DB</sub>	Control supply voltage	Applied between $V_{B(U)}$ - $V_{S(U)}$ , $V_{B(V)}$ - $V_{S(V)}$ , $V_{B(W)}$ - $V_{S(W)}$	20	V
V <sub>IN</sub>	Input voltage	$\begin{array}{c} \text{Applied between IN}_{(\text{HU})},  \text{IN}_{(\text{HV})},  \text{IN}_{(\text{HW})}, \\ \text{IN}_{(\text{LU})},  \text{IN}_{(\text{LV})}, \! \text{IN}_{(\text{LW})} )^{-} COM \end{array}$	-0.3~VD+0.3	V
V <sub>FO</sub>	Fault output supply voltage	Applied between V <sub>FO</sub> -COM	-0.3~V <sub>D</sub> +0.3	V
I <sub>FO</sub>	Fault output current	Sink current at V <sub>FO</sub> terminal	5.0	mA
V <sub>CIN</sub>	Current sensing input voltage	Applied between C <sub>IN</sub> -COM	-0.3~V <sub>D</sub> +0.3	V

### **Bootstrap Diode Part**

Symbol	Parameter	Conditions	Ratings	Units
$V_{RRM}$	Maximum Repetitive Reverse Voltage		600	V
I <sub>F</sub>	Forward Current	TC = 25°C	0.5	Α
I <sub>FP</sub>	Forward Current (Peak)	T <sub>C</sub> = 25°C, Under 1ms Pulse Width	2	Α
TJ	Junction temperature		-20~+125	°C

### **Total System**

Symbol	Parameter	Conditions	Ratings	Units



V <sub>PN(PROT)</sub>	Self protection supply voltage limit (short circuit protection capability)	$V_D$ = 13.5~16.5V, inverter part $T_J$ = 125°C,non-repetitive,less than 5us	400	V
T <sub>C</sub>	Module case operation temperature	–20 °C≤T <sub>J</sub> ≤125 °C	-20~+100	°C
T <sub>STG</sub>	Storage temperature		-40~+125	°C
V <sub>ISO</sub>	Isolation voltage	60Hz, sinusoidal, AC 1 minute, connecting pins to heat-sink plate	2500	Vrms

### **Thermal Resistance**

Symbol	Parameter	Conditions	Limits			Units
Symbol	r didilictor	Conditions	Min.	Тур.	Max.	Omis
Rth(j-c)Q	Junction to case	Inverter IGBT part (per 1/6 module)	-	-	2.02	°C/W
Rth(j-c)F	thermal resistance	Inverter FRD part (per 1/6 module)	-	-	3.15	°C/W

## Electrical Characteristics (T<sub>J</sub> = 25°C, unless otherwise noted)

### **Inverter Part**

Symbol		Parameter Conditions			Limits		Units
		Parameter	Conditions	Min.	Тур.	Max.	Units
V <sub>CE</sub>	Collector-emitter $V_D = V_{BS} = 15V, V_{IN} = 5V, I_C = 15A, T_J = 25^{\circ}C$			2.0	2.3	V	
'	V <sub>F</sub>	FRD forward voltage	V <sub>IN</sub> =0V , I <sub>C</sub> =10A, T <sub>J</sub> =25°C		1.6	2.0	
	ton				680		
HS	tc(on)		$V_{PN}$ =300V, $V_{D}$ = $V_{BS}$ =15V $I_{C}$ = 15A, $V_{IN}$ = 0 $\leftrightarrow$ 5V Inductive load ( <b>Note 2</b> )		200		
пъ	toff				850		
	tc(off)				150		20
	ton	Switching times			630		ns
1.0	tc(on)		, ,		240		
LS	toff				850		
	tc(off)				160		
Id	CES	Collector-emitter leakage current	V <sub>CE</sub> =V <sub>CES</sub> ,V <sub>GE</sub> =0V, T <sub>J</sub> =25°C			100	μA

Note 2: ton and toff include the propagation delay time of the internal drive IC. tc(on) and tc(off) are the switching time of IGBT itself under the given gate driving condition internally. See figure 3.

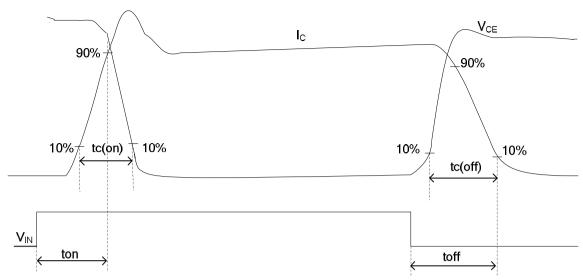


Fig 3. Switching Time Definition

### **Control Part**

0	D	Conditions		Limits			11 - 14 -
Symbol	Parameter			Min.	Тур.	Max.	Units
I <sub>DL</sub>	Quiescent V <sub>D</sub>	$V_D$ =15V,IN( $LU,LV$ ) LW) =0V	V <sub>D(L)</sub> -COM			600	μA
I <sub>DH</sub>	supply current	$V_D=15V,IN(HU,HV,HW)$	$V_{D(HU)}, V_{D(HV)}, V_{D(HW)} - COM$			300	
I <sub>QBS</sub>	Quiescent V <sub>BS</sub> supply current	$V_{BS}$ =15V,IN( $HU,HV$ )	$V_{B(U)}$ - $V_{S(U)}$ , $V_{B(V)}$ - $V_{S(W)}$			150	μA
$V_{FOH}$	Fault output	V <sub>SC</sub> =0V,V <sub>FO</sub> circuit:	4.7K to 5V pull-up	4.5			
V <sub>FOL</sub>	voltage	V <sub>SC</sub> =1V,V <sub>FO</sub> circuit:4.7K to 5V pull-up				8.0	V
V <sub>CIN(ref)</sub>	Short circuit trip level	TC = -20~100°C, V <sub>D</sub> = 15V ( <b>Note3</b> )		0.44	0.51	0.56	
UV <sub>DLD</sub>		Detection level (LS	3)	11.0	12.0	13.0	
UV <sub>DLR</sub>	Supply circuit	Rest level (LS)		12.0	13.0	14.0	V
UV <sub>BSD</sub>	under-voltage protection	Detection level (H	S)	9.0	10.0	11.0	
UV <sub>BSR</sub>	'	Rest level (HS)		10.0	11.0	12.0	
1	Fault-out pulse	C <sub>FO</sub> =26nF (Note4	)		1.80		
t <sub>FO</sub>	width	C <sub>FO</sub> =33nF( <b>Note4</b> )			2.30		ms
V <sub>IN(ON)</sub>	ON threshold voltage	Applied between IN <sub>(HU)</sub> , IN <sub>(HV)</sub> , IN <sub>(HW)</sub> ,		3.0			V
V <sub>IN(OFF)</sub>	OFF threshold voltage	$IN_{(LU)},IN_{(LV)},IN_{(LW)}$ -C	COM			0.8	V

Note 3 : Short circuit protection is functioning only at the low-side. Note 4 : The fault output pulse-width  $t_{FO}$  depends on the capacitance value of  $C_{FO}$  according to the following approximate equation :  $C_{FO} \approx 14.3 * 10^{-6} * t_{FO}$  [F].

### **Bootstrap Diode Part**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
V <sub>F</sub>	Forward Voltage	$I_F = 0.5A, T_C = 25^{\circ}C$		1.15		V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 0.5A, T <sub>C</sub> = 25°C		40		ns

# **Mechanical Characteristics and Ratings**

Parameter	Conditions			Limits		
Parameter				Тур.	Max.	Units
Mounting torque	Mounting screw: - M3	Recommended 0.62N.m	0.51	0.62	0.72	N.m
Weight				15.0		g
Device flatness		(See Fig 4)	0		120	um

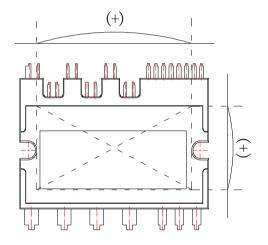


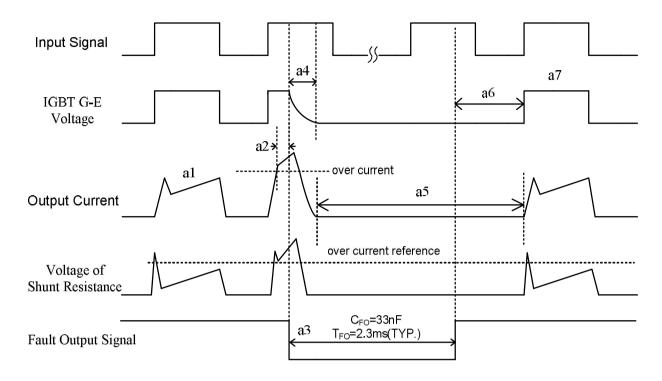
Fig 4. Flatness Measurement Position

# **Recommended Operating Conditions**

Symbol	Parameter	Conditions	Recommened value			
		Conditions		Тур.	Max.	Units
$V_{PN}$	Supply voltage	Applied between P -N <sub>U</sub> ,N <sub>V</sub> ,N <sub>W</sub>		300	400	
V <sub>D</sub>	Control supply voltage	Applied between $V_{D(HU)}$ , $V_{D(HV)}$ , $V_{D(HW)}$ , $V_{D(L)}$ -COM	13.5	15.0	16.5	V
V <sub>BS</sub>	High-side bias voltage	Applied between $V_{B(U)}$ - $V_{S(U)}$ , $V_{B(V)}$ - $V_{S(V)}$ , $V_{B(W)}$ - $V_{S(W)}$	13.5	15.0	18.5	
$\Delta V_D$ , $\Delta V_{DB}$	Control supply variation		-1		1	V/µs
t <sub>DEAD</sub>	Blanking time for preventing arm-short	For each input signal	2.0			μs
$f_{PWM}$	PWMinput signal	-20°C≤T <sub>C</sub> ≤100°C, -20°C≤T <sub>J</sub> ≤125°C			20	KHz
V <sub>SEN</sub>	Voltage for current sensing	Applied between N <sub>U</sub> ,N <sub>V</sub> ,N <sub>W</sub> -COM (Including surge voltage)	-4		4	V

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### **Time charts of IPM Protection Function**



**Fig 5.Over Current Protection** 

(Low-side only ,with the external shunt resistance and RC filter)

- a1 Normal operation: IGBT ON and carrying current
- a2 Over current detection and filter
- a3 Fault output timer operation starts: The pulse width of the V<sub>FO</sub> is set by the external capacitor C<sub>FO</sub>
- a4 IGBT turns off softly
- a5 IGBT OFF state
- a6 V<sub>FO</sub> finishes output,but IGBTs don't turn on until inputting next ON signal.
- a7 Normal operation: IGBT ON and outputs current by next ON signal( $L\rightarrow H$ ).

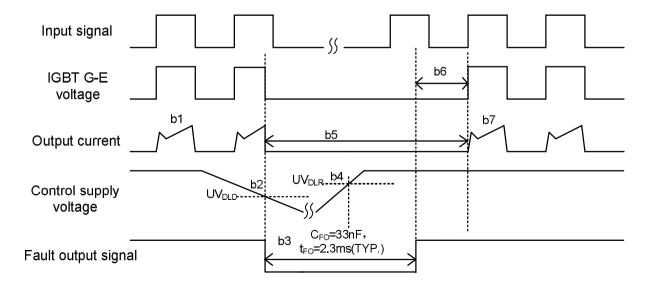


Fig 6.Under-Voltage Protection of Low-side

- b1 Normal operation: IGBT ON and carrying current
- b2 Under voltage detection (UV<sub>DLD</sub>)
- b3 Fault output timer operation starts: The pulse width of the V<sub>FO</sub> is set by the external capacitor C<sub>FO</sub>
- b4 Under voltage reset (UV<sub>DLR</sub>)
- b5 IGBT OFF state
- b6 VFO finishes output, but IGBTs don't turn on until inputting next ON signal.
- b7 Normal operation: IGBT ON and outputs current by next ON signal(L→H).

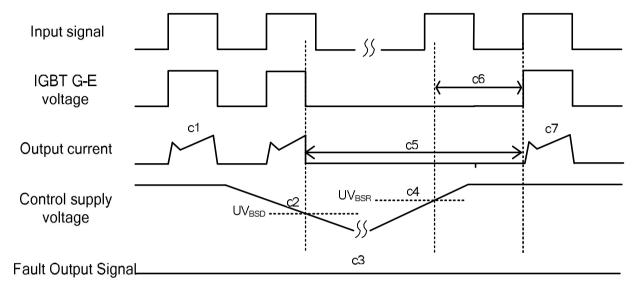


Fig 7.Under-Voltage Protection of High-side

- c1 Normal operation: IGBT ON and carrying current
- c2 Under voltage detection (UV<sub>BSD</sub>)
- c3 No fault output signal
- c4 Under voltage reset (UV<sub>BSR</sub>)
- c5 IGBT OFF state
- c6 Under voltage reset, but IGBTs don't turn on until inputting next ON signal.
- c7 Normal operation: IGBT ON and outputs current by next ON signal( $L\rightarrow H$ ).

# **Internal Equivalent Circuit and Input/Output Pins**

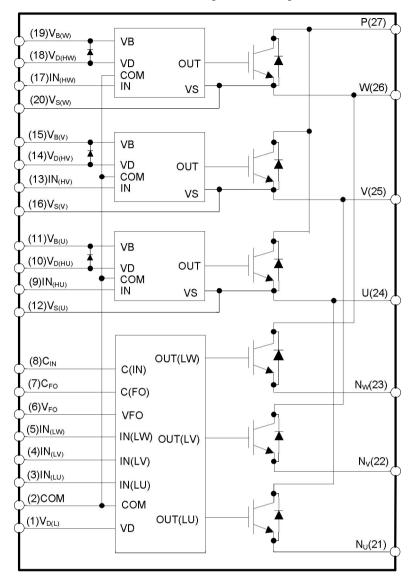


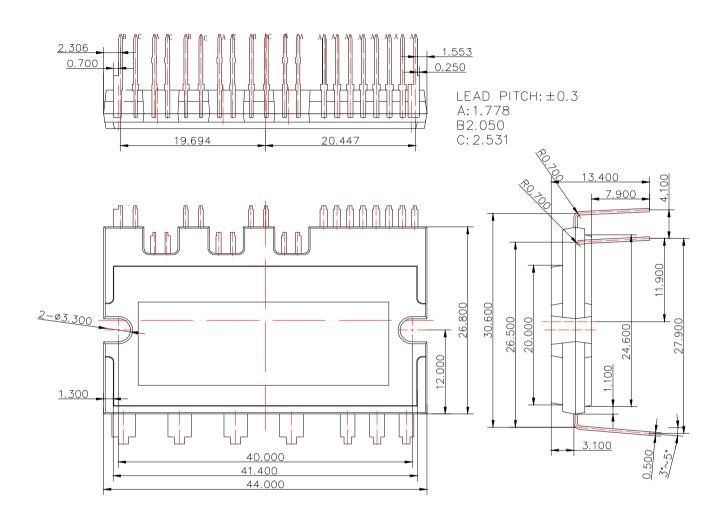
Fig 8. Internal Equivalent Circuit and Input/Output Pins

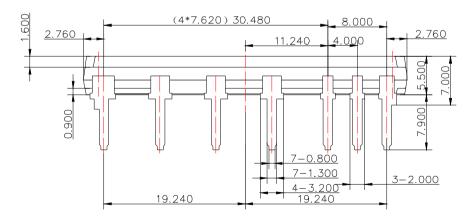
#### Note:

- 1. Inverter low-side is composed of three IGBTs, freewheeling diodes for each IGBT and one control IC. It has gate drive and protection functions
- 2. Inverter power side is composed of four inverter dc-link input terminals and three inverter output terminals
- 3. Inverter high-side is composed of three IGBTs, freewheeling diodes, bootstrap diodes and three drive ICs for each IGBT

# **Detailed Package Outline Drawings (Unit: mm)**

Package:BIP27-4426





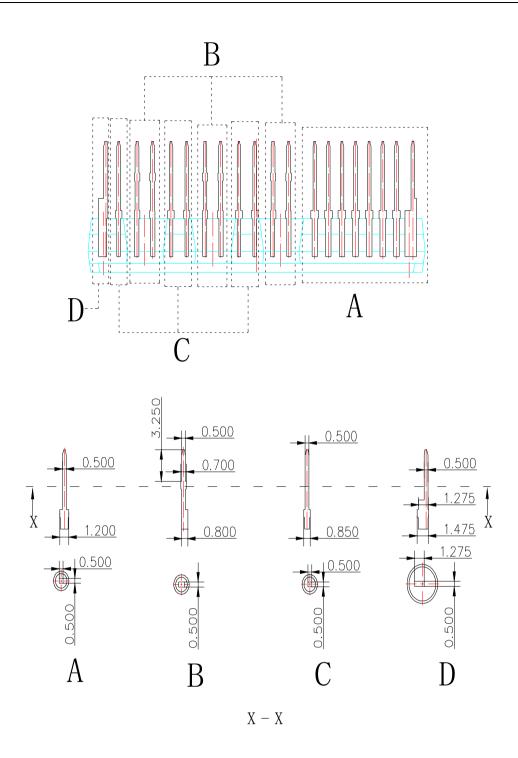


Fig 9.Detailed Package Outline Drawings

# **Packing**

package	pcs/tube	tube/ inner box	inner box/ carton	pcs/carton
tube	10	7	5	350



#### **RESTRICTIONS ON PRODUCT USE**

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